

P22032.A07



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants : Mitsuru TAKAI et al.

Group Art Unit: 2641

Appln. No. : 10/084,177

Examiner: Hadi AKHVANNIK

Filed : February 28, 2002

Conformation No.: 4788

For : NEXT PROCESS-DETERMINING METHOD, INSPECTING METHOD
AND INSPECTING APPARATUS

REQUEST FOR EXTENSION OF TIME

Commissioner for Patents
U.S. Patent and Trademark Office
Customer Service Window, Mail Stop
Randolph Building
401 Dulany Street
Alexandria, VA 22314

Sir:

Please extend the time for response to the Official Action dated February 22, 2006 by one month, from May 22, 2006 to June 22, 2006. The amount of \$120.00 is enclosed as payment for the fee.

The U.S. Patent and Trademark Office is hereby authorized to credit any overpayment or charge any additional fee to Deposit Account No. 19-0089.

Respectfully submitted,
Mitsuru TAKAI et al.

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06/23/2006 JADD01

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120.00 OP

June 20, 2006
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